NPN-Silizium-Fototransistor im SMT SIDELED®-Gehäuse
Silicon NPN Phototransistor in SMT SIDELED®-Package

SFH 325
SFH 325 FA

SFH 325

SFH 325 FA

Wesentliche Merkmale

- Speziell geeignet für Anwendungen im Bereich von 380 nm bis 1150 nm (SFH 325) und bei 880 nm (SFH 325 FA)
- Hohe Linearität
- P-LCC-2 Gehäuse
- Gruppiert lieferbar
- Nur für Reflow IR-Lötung geeignet.

Features

- Especially suitable for applications from 380 nm to 1150 nm (SFH 325) and of 880 nm (SFH 325 FA)
- High linearity
- P-LCC-2 package
- Available in groups
- Suitable only for reflow IR soldering.

Anwendungen

- Miniaturlichtschranken für Gleich- und Wechsellichtbetrieb
- Lochstreifenleser
- Industrieelektronik
- „Messen/Steuern/Regeln“

Applications

- Miniature photointerrupters
- Punched tape readers
- Industrial electronics
- For control and drive circuits

Typ Type	Bestellnummer Ordering Code	Typ Type	Bestellnummer Ordering Code
SFH 325	Q6[1)]2702-P1638	SFH 325 FA	Q62702-P1639
SFH 325-3	Q62702-P1610	SFH 325 FA-3	Q62702-P1724
SFH 325-3/-4	Q62702-P3604	SFH 325 FA-3/-4	Q62702-P3603
SFH 325-4	Q62702-P1611	SFH 325 FA-4	Q62702-P1615

1)

Opto Semiconductors OSRAM

Grenzwerte
Maximum Ratings

Bezeichnung **Parameter**	**Symbol** **Symbol**	**Wert** **Value**	**Einheit** **Unit**
Betriebs- und Lagertemperatur Operating and storage temperature range	T_{op}; T_{stg}	– 40 … + 100	°C
Kollektor-Emitterspannung Collector-emitter voltage	V_{CE}	35	V
Kollektorstrom Collector current	I_C	15	mA
Kollektorspitzenstrom, $\tau < 10$ µs Collector surge current	I_{CS}	75	mA
Verlustleistung, $T_A = 25$ °C Total power dissipation	P_{tot}	165	mW
Wärmewiderstand für Montage auf PC-Board Thermal resistance for mounting on pcb	R_{thJA}	450	K/W

Kennwerte (T_A = 25 °C, λ = 950 nm)
Characteristics

Bezeichnung **Parameter**	**Symbol** **Symbol**	**Wert** **Value**		**Einheit** **Unit**
		SFH 325	**SFH 325 FA**	
Wellenlänge der max. Fotoempfindlichkeit Wavelength of max. sensitivity	$\lambda_{S\ max}$	860	900	nm
Spektraler Bereich der Fotoempfindlichkeit S = 10% von S_{max} Spectral range of sensitivity S = 10% of S_{max}	λ	380 … 1150	730 … 1120	nm
Bestrahlungsempfindliche Fläche (∅ 220 µm) Radiant sensitive area	A	0.038	0.038	mm^2
Abmessung der Chipfläche Dimensions of chip area	$L \times B$ $L \times W$	0.45 × 0.45	0.45 × 0.45	mm × mm
Abstand Chipoberfläche zu Gehäuseoberfläche Distance chip front to case surface	H	0.5 … 0.7	0.5 … 0.7	mm
Halbwinkel Half angle	φ	± 60	± 60	Grad deg.
Kapazität, V_{CE} = 0 V, f = 1 MHz, E = 0 Capacitance	C_{CE}	5.0	5.0	pF
Dunkelstrom Dark current V_{CE} = 25 V, E = 0	I_{CEO}	1 (≤ 200)	1 (≤ 200)	nA

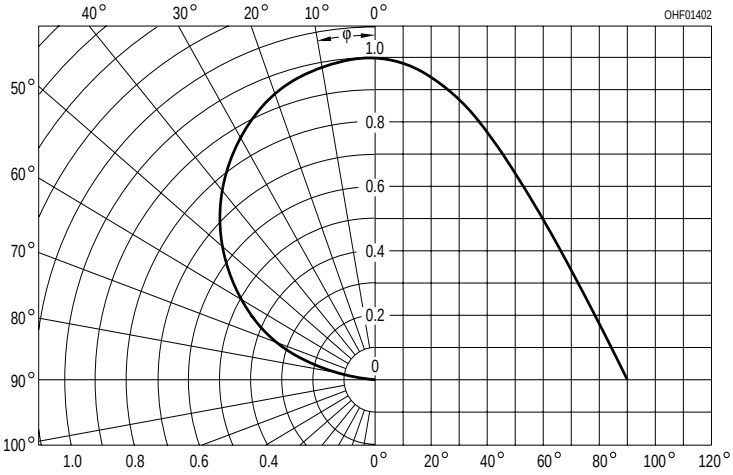
Die Fototransistoren werden nach ihrer Fotoempfindlichkeit gruppiert und mit arabischen Ziffern gekennzeichnet.
The phototransistors are grouped according to their spectral sensitivity and distinguished by arabian figures.

Bezeichnung Parameter	Symbol Symbol	Wert Value				Einheit Unit
		SFH 325 /FA	-2	-3	-4	
Fotostrom, $\lambda = 950$ nm Photocurrent E_e = 0.1 mW/cm², V_{CE} = 5 V	I_{PCE}	≥ 16	16 … 32	25 … 50	40 … 80	µA
SFH 325: E_v = 1000 lx, Normlicht/standard light A, V_{CE} = 5 V	I_{PCE}	–	420	650	1000	µA
Anstiegszeit/Abfallzeit Rise and fall time I_C = 1 mA, V_{CC} = 5 V, R_L = 1 kΩ	t_r, t_f	7	6	7	8	µs
Kollektor-Emitter-Sättigungsspannung Collector-emitter saturation voltage $I_C = I_{PCEmin}$ [1] × 0.3, E_e = 0.1 mW/cm²	V_{CEsat}	150	150	150	150	mV

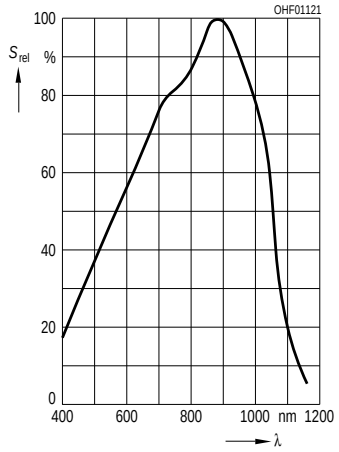
[1] I_{PCEmin} ist der minimale Fotostrom der jeweiligen Gruppe.

[1] I_{PCEmin} is the min. photocurrent of the specified group.

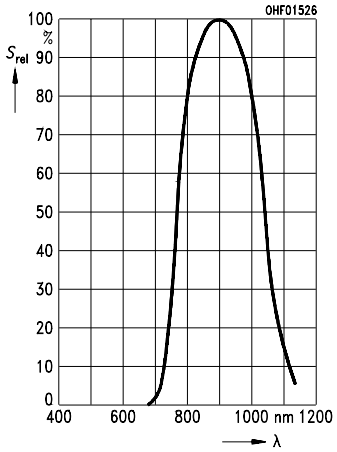
Directional Characteristics $S_{rel} = f(\varphi)$



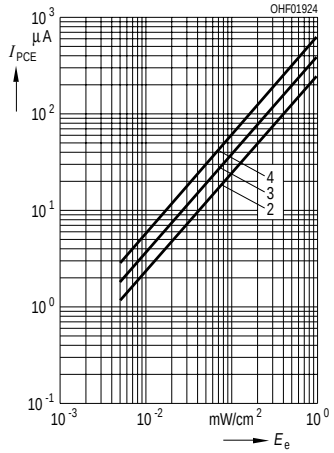
Relative Spectral Sensitivity,
SFH 325 $S_{rel} = f(\lambda)$



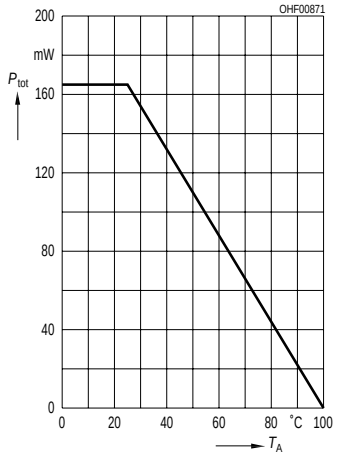
Relative Spectral Sensitivity,
SFH 325 FA $S_{rel} = f(\lambda)$



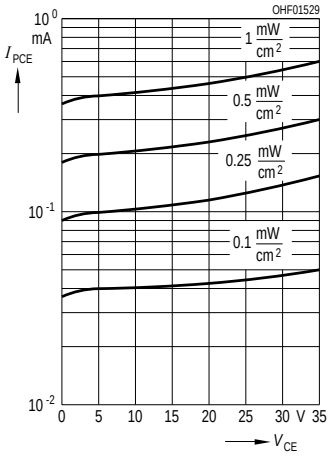
Photocurrent
$I_{PCE} = f(E_e)$, V_{CE} = 5 V



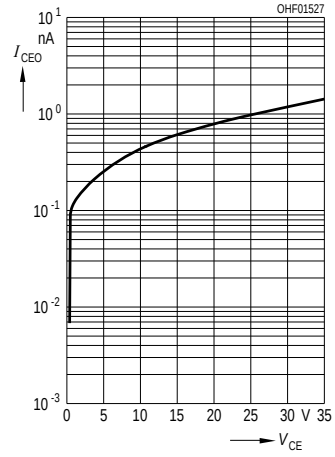
Total Power Dissipation
$P_{tot} = f(T_A)$



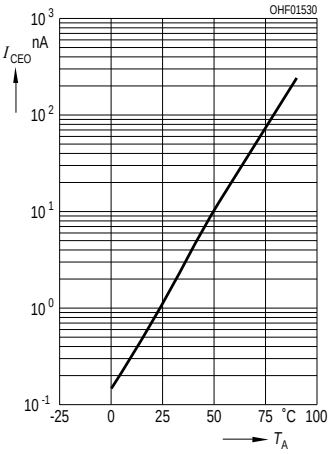
Photocurrent
$I_{PCE} = f(V_{CE})$, E_e = Parameter



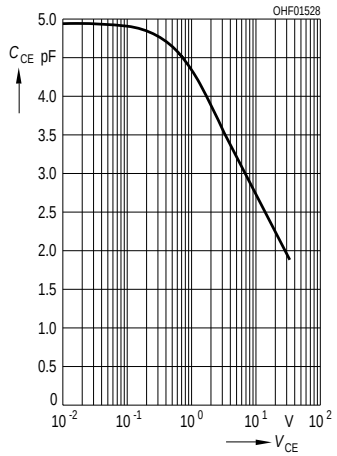
Dark Current
$I_{CEO} = f(V_{CE})$, E = 0



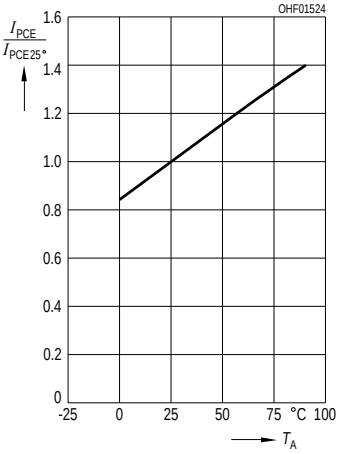
Dark Current
$I_{CEO} = f(T_A)$, V_{CE} = 5 V, E = 0



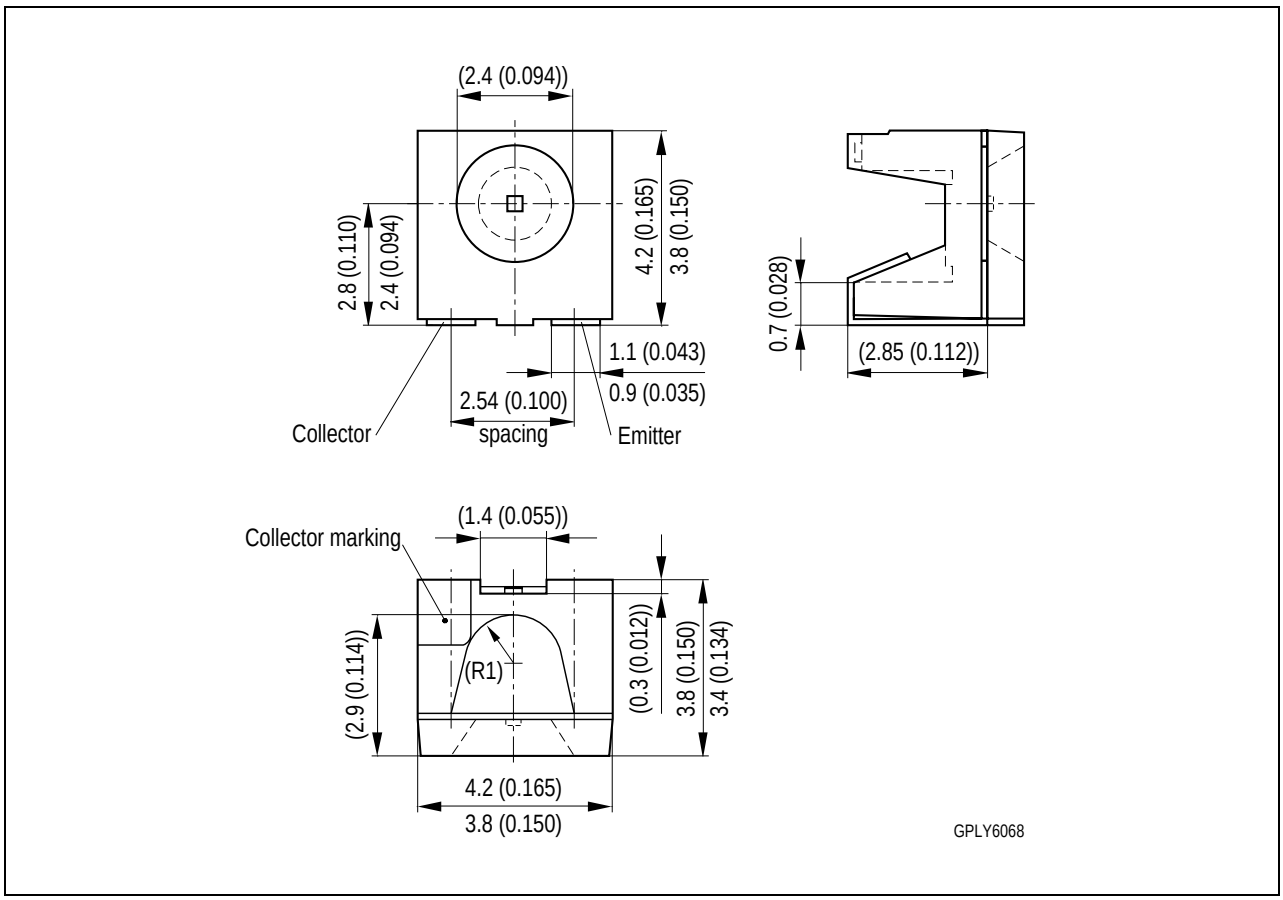
Capacitance
$C_{CE} = f(V_{CE})$, f = 1 MHz, E = 0



Photocurrent
$I_{PCE}/I_{PCE25°} = f(T_A)$, V_{CE} = 5 V



Maßzeichnung
Package Outlines



Maße werden wie folgt angegeben: mm (inch) / Dimensions are specified as follows: mm (inch).

Löthinweise
Soldering Conditions

Bauform Types	Tauch-, Schwall- und Schlepplötung Dip, Wave and Drag Soldering			Reflowlötung Reflow Soldering	
	Lötbad-temperatur Temperature of the Soldering Bath	Maximal zulässige Lötzeit Max. Perm. Soldering Time	Abstand Lötstelle – Gehäuse Distance between Solder Joint and Case	Lötzonen-temperatur Temperature of Soldering Zone	Maximale Durchlaufzeit Max. Transit Time
SIDELED	–	–	–	245 °C	10 s

Zusätzliche Informationen über allgemeine Lötbedingungen erhalten Sie auf Anfrage.

For additional information on general soldering conditions please contact us.

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Packing
Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.
Components used in life-support devices or systems must be expressly authorized for such purpose! Critical components [1] , may only be used in life-support devices or systems [2] with the express written approval of OSRAM OS.
[1] A critical component is a component usedin a life-support device or system whose failure can reasonably be expected to cause the failure of that life-support device or system, or to affect its safety or effectiveness of that device or system.
[2] Life support devices or systems are intended (a) to be implanted in the human body, or (b) to support and/or maintain and sustain human life. If they fail, it is reasonable to assume that the health of the user may be endangered.